PXIe-4163 Specifications



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PXIe-4163 Specifications



Note In this document, the PXIe-4163 (10 pA) and PXIe-4163 (100 pA) are referred to inclusively as the PXIe-4163.

The information in this document applies to all versions of the PXIe-4163 unless otherwise specified. Use the information in the following table to confirm your module variant.

Table 1. PXIe-4163 Variant Identification

Model	Location	Identifying Information
PXIe-4163 (10 pA)	NI Measurement & Automation Explorer (MAX)	PXIe-4163 (10 pA)
	Device Front Panel	PXIe-4163 24-CH 10pA SMU
PXIe-4163 (100 pA)	NI Measurement & Automation Explorer (MAX)	PXIe-4163
	Device Front Panel	PXIe-4163 24-CH Precision SMU

Definitions

Warranted specifications describe the performance of a model under stated operating conditions and are covered by the model warranty.

Characteristics describe values that are relevant to the use of the model under stated operating conditions but are not covered by the model warranty.

- Typical specifications describe the performance met by a majority of models.
- **Typical-95** specifications describe the performance met by 95% (\approx 2 σ) of models with a 95% confidence.
- **Nominal** specifications describe an attribute that is based on design, conformance testing, or supplemental testing.

Specifications are **Nominal** unless otherwise noted.

Conditions

Specifications are valid under the following conditions unless otherwise noted.

- Ambient temperature¹ of 23 °C ± 5 °C
- Chassis with slot cooling capacity ≥38 W²
 - For chassis with slot cooling capacity = 38 W, fan speed set to HIGH
- Calibration interval of 1 year
- 30 minutes warm-up time
- Self-calibration performed within the last 24 hours
- NI-DCPower Aperture Time is set to 2 power-line cycles (PLC)

Instrument Capabilities

Channels	0 through 23
DC voltage range	±24 V

The following table and figure illustrate the voltage and the current source and sink ranges of the PXIe-4163.

Table 2. PXIe-4163 DC Current Source and Sink Ranges, Warranted

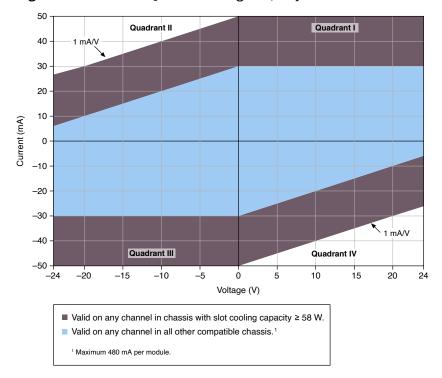
Device Model	Chassis Slot Cooling Capacity	
	≥58 W	38 W
PXIe-4163 (10 pA) only	1 μΑ	1 μΑ
All PXIe-4163 models	10 μΑ	10 μΑ
All PXIe-4163 models	100 μΑ	100 μΑ
All PXIe-4163 models	1 mA	1 mA

¹ The ambient temperature of a PXI system is defined as the temperature at the chassis fan inlet (air intake).

² For increased capability, NI recommends installing the PXIe-4163 in a chassis with slot cooling capacity ≥58 W.

Device Model	Chassis Slot Cooling Capacity	
	≥58 W	38 W
All PXIe-4163 models	10 mA	10 mA
All PXIe-4163 models	50 mA	30 mA

Figure 1. PXIe-4163 Quadrant Diagram, Any Channel



Voltage

Table 3. Voltage Programming and Measurement Accuracy/Resolution, Warranted

		Accuracy (23 °C ± 5 °C) ± (% of Voltage + Offset) ³ T _{cal} ± 5 °C	Tempco ⁴ ± (% of Voltage + Offset)/°C, 0 °C to 55 °C
24 V	200 μV	0.05% + 5 mV	0.0005% + 1 μV

³ Refer to remote sense and load regulation sections for additional accuracy derating and conditions.

⁴ Temperature coefficient applies beyond 23 °C ± 5 °C within 5 °C of T_{cal}.

Current

Table 4. PXIe-4163 (10 pA) Current Programming and Measurement Accuracy/Resolution, Warranted

Range	Resolution and Noise (0.1 Hz to 10 Hz, peak- to-peak, typical)	Accuracy (23 °C ± 5 °C) ± (% of Current + Offset) ⁵	Tempco ⁶ ± (% of Current + Offset)/°C, 0 °C to 55 °C
		T _{cal} ± 5 °C	
1 μΑ	10 pA	0.10% + 100 pA	0.004% + 20 pA
10 μΑ	100 pA	0.10% + 1 nA	0.004% + 20 pA
100 μΑ	1 nA	0.10% + 10 nA	0.004% + 100 pA
1 mA	10 nA	0.10% + 100 nA	0.004% + 1 nA
10 mA	100 nA	0.10% + 1 μΑ	0.004% + 10 nA
30 mA or 50 mA ⁷	500 nA	0.10% + 5 μΑ	0.004% + 50 nA

Table 5. PXIe-4163 (100 pA) Current Programming and Measurement Accuracy/Resolution, Warranted

Range	Resolution and Noise (0.1 Hz to 10 Hz, peak- to-peak, typical) ⁸	Accuracy (23 °C ± 5 °C) ± (% of Current + Offset) ⁹	Tempco ¹⁰ ± (% of Current + Offset)/°C, 0 °C to 55 °C
		T _{cal} ± 5 °C	
10 μΑ	100 pA	0.10% + 5 nA	0.004% + 10 pA
100 μΑ	1 nA	0.10% + 50 nA	0.004% + 100 pA
1 mA	10 nA	0.10% + 500 nA	0.004% + 1 nA
10 mA	100 nA	0.10% + 5 μΑ	0.004% + 10 nA
30 mA or 50 mA ¹¹	500 nA	0.10% + 25 μΑ	0.004% + 50 nA

⁵ Refer to remote sense and load regulation sections for additional accuracy derating and conditions.

⁶ Temperature coefficient applies beyond 23 °C ± 5 °C within 5 °C of T_{cal}.

⁷ 50 mA range available only when installed in chassis with slot cooling capacity ≥58 W. 30 mA range available in all other chassis.

 $^{^{8}\,}$ Specified values apply for $V_{output\,HI}\,{\le}5$ V; add 0.0002% of range per volt above 5 V .

⁹ Refer to remote sense and load regulation sections for additional accuracy derating and conditions.

¹⁰ Temperature coefficient applies beyond 23 °C \pm 5 °C within 5 °C of T_{cal} .

Available DC Output Power

Chassis Slot Cooling Capacity	Per Channel Maximum	Absolute Maximum
≥58 W	1.2 W	28.8 W
38 W	0.7 W	11.5 W

Additional Specifications

Settling time ¹²		<500 μs, typical ¹³	
Transient response ¹⁴		<100 μs, typical ¹⁵	
Wideband source noise	16		15 mV RMS, typical
			<100 mV, peak-to-peak, typical
Remote Sense	Voltage		No additional error due to lead drop
	Current		No additional error due to lead drop
	Maximum lead drop	Maximum lead drop	
Load regulation	Voltage ¹⁷		50 μV/mA, typical
	Current		(30 pA + 20 ppm of range)/volt, typical
Functional isolation voltage, any pin to earth ground		60 V DC	
Absolute maximum voltage to Output LO	From Sense HI ¹⁸	When V _{Output HI} > 0 V	-0.5 V to (V _{Output HI} + 0.5 V)

¹¹ 50 mA range available only when installed in chassis with slot cooling capacity ≥58 W. 30 mA range available in all other chassis.

¹² Current limit set to ≥1 mA and ≥10% of the selected current limit range. PXIe-4163 configured for fast transient response.

¹³ To settle to 0.1% of voltage step.

¹⁴ PXIe-4163 configured for fast transient response.

¹⁵ To recover within ±20 mV after a load current change from 10% to 90% of range.

¹⁶ 20 Hz to 20 MHz bandwidth. PXIe-4163 configured for normal transient response. Measured at the end of the 1 m SHDB62M-DB62M-LL cable.

¹⁷ At connector pins when using local sense.

¹⁸ Where V_{Output HI} is the voltage at the Output HI pin in the same channel as a Sense HI pin.

	When V _{Output HI} ≤ 0 V	(V _{Output HI} - 0.5 V) to 0.5 V
From all other pins		±25 V



Notice Exceeding the absolute maximum voltage from Sense HI to Output LO when using remote sense can result in a Remote Sense OVP Error in NI-DCPower 23.0 and later.

The following figures illustrate noise as a function of measurement aperture for the PXIe-4163.

Figure 2. Voltage RMS Noise Versus Aperture Time, 19 Typical

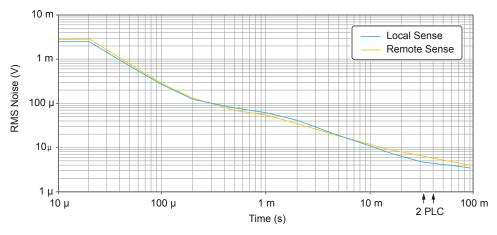
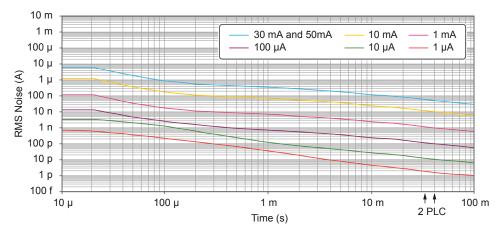


Figure 3. Current RMS Noise Versus Aperture Time, 20, 21 Typical



¹⁹ All channels averaged. Channels 9 and 22 have degraded performance.

 $^{^{\}rm 20}~$ The 1 μA range applies only to the PXIe-4163 (10 pA).



Note When the aperture time is set to two power-line cycles (PLCs), measurement noise differs slightly depending on whether the niDCPower Power Line Frequency is set to 50 Hz or 60 Hz.



Note To configure DC Noise rejection, set the niDCPower DC Noise Rejection to normal or second-order.

Measurement and Update Timing

Available sample rates ²²	(600 kS/s)/N
where	
• $N = 6, 7, 8, \dots 2^{20}$	
S is samples	
Sample rate accuracy	±50 ppm
Maximum measure rate to host ²³	100,000 S/s per channel, continuous
Maximum source update rate ²⁴	
Single channel	100,000 updates/s
All channels simultaneously	40,000 updates/s per channel

²¹ All channels averaged. For the PXIe-4163 (100 pA), channels 7, 9, and 11 have degraded performance.

When source-measuring, both the NI-DCPower Source Delay and Aperture Time properties affect the sampling rate. When taking a measure record, only the Aperture Time property affects the sampling rate.

²³ Load dependent settling time is not included. Normal DC noise rejection is used.

²⁴ As the source delay is adjusted or if advanced sequencing is used, maximum source update rates may vary.

Input trigger to	
Source event delay	8.5 μs
Source event jitter	1.7 μs
Measure event jitter	1.7 μs

Triggers



Note Pulse widths and logic levels for PXI trigger lines 0 to 7 are compliant with **PXI Express Hardware Specification Revision 1.0 ECN 1**.

Table 6. Input Triggers

Types		Start	
		Source	
		Sequence Advance	
		Measure	
Sources (PXI trigger lines 0 to 7)	Polarity	Active high (not configurable)	
	Minimum pulse width	100 ns	
Destinations ²⁵ (PXI trigger lines 0 to 7)	Polarity	Active high (not configurable)	
	Minimum pulse width	>200 ns	

Table 7. Output Triggers (Events)

Types		Source Complete
		Sequence Iteration Complete
		Sequence Engine Done
		Measure Complete
Destinations (PXI trigger lines 0 to 7)	Polarity	Active high (not configurable)
	Pulse width	230 ns

²⁵ Input triggers can come from any source (PXI trigger or software trigger) and be exported to any PXI trigger line. This allows for easier multi-board synchronization regardless of the trigger source.

Calibration Interval

Recommended calibration interval	1 year

Physical

Dimensions	3U, one-slot, PXI Express/CompactPCI Express module	
	2.0 cm × 13.0 cm × 21.6 cm (0.8 in. × 5.1 in. × 8.5 in.)	
Weight	394 g (13.9 oz)	
Front panel connector	Custom 62-position D-SUB, female	

Power Requirements

Chassis Slot	+3.3 V Current Draw, Typical		+12 V Current Draw, Typical	
Cooling Capacity	Idle	Full Output Load	Idle	Full Output Load
38 W	1 A	1 A	1.5 A	3 A
≥58 W		1 A		4.5 A

Environmental Characteristics

Temperature	Operating	Chassis with slot cooling capacity ≥58 W ²⁶	0 °C to 55 °C
		All other compatible chassis	0 °C to 40 °C
	Storage		-40 °C to 71 °C

²⁶ Not all chassis with slot cooling capacity ≥58 W can achieve this ambient temperature range. Refer to PXI chassis specifications to determine the ambient temperature ranges your chassis can achieve.

Humidity	Operating	10% to 90%, noncondensing
	Storage	5% to 95%, noncondensing
Pollution Degree		2
Maximum altitude		2,000 m (800 mbar) (at 25 °C ambient temperature)
Shock and Vibration	Operating vibration	5 Hz to 500 Hz, 0.3 g RMS
	Non-operating vibration	5 Hz to 500 Hz, 2.4 g RMS
	Operating shock	30 g, half-sine, 11 ms pulse